

FCC - TEST REPORT

Report Number	:	68.950.15.003.0)1	Date of Issue:	Jan 22, 2015
Model	<u>:</u>	WIP-D40, ISOU	ND-6710		
Product Type	<u>:</u>	Wireless Speak	er		
Applicant	<u>:</u>	WINLITE INTER	RNATIONA	L (HK) LTD	
Address	<u>:</u>	Room 1401, To	wer A, Tiaı	n An Cyber Times,	Shennan Avenue,
		Futian District S	henzhen,	China	
Production Facility	: WINLITE INTERNATIONAL (HK) LTD				
Address	<u>:</u>	Room 1401, To	wer A, Tiaı	n An Cyber Times,	Shennan Avenue,
		Futian District S	henzhen, (China	
Test Result	:	■ Positive	☐ Negativ	ve	
Total pages including Appendices		42			
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2 Details about the Test Laboratory

Details about the Test Laboratory

Test Site 1

Company name: TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch

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Nantou Checkpoint Road 2, Nanshan District,

Shenzhen City, 518052,

P. R. China

Telephone: 86 755 8828 6998 Fax: 86 755 8828 5299



3 Description of the Equipment Under Test

Product: Wireless Speaker

Model no.: WIP-D40, ISOUND-6710

FCC ID: A6JD40

Brand Name: Winlite[®], I.SOUND

Options and accessories: USB Cable, Audio-in Cable

Rating: DC3.7V (supplied by Lithium rechargeable battery)

DC5V (charged by USB port)

RF Transmission

Frequency:

2402-2480MHz

No. of Operated Channel: 79

Modulation: GFSK, $\pi/4$ -DQPSK, 8DPSK

Duty Cycle: 33.16%

Antenna Type: PCB Antenna

Antenna Gain: 0dBi

Description of the EUT: The Equipment Under Test EUT is a Wireless Speaker with

Bluetooth function operating at 2.4GHz



4 Summary of Test Standards

	Test Standards
FCC Part 15 Subpart C	PART 15 - RADIO FREQUENCY DEVICES
10-1-2014 Edition	Subpart C - Intentional Radiators

All the test methods were according to Public Notice DA 00-705 -Frequency Hopper Spread Spectrum Test Procedure released by FCC on March 30, 2000 and C63.10 (2009).



5 Summary of Test Results

Technical Requirements						
FCC Part 15 Subpart C						
Test Condition		Pages	Test Site	Test Result		
§15.207	Conducted emission on AC power port	10	Site 1	N/A		
§15.247(b)(1)	Conducted peak output power	13	Site 1	Pass		
§15.247(a)(2)	6dB bandwidth			N/A		
§15.247(a)(1)	20dB bandwidth and 99% Occupied Bandwidth	14	Site 1	Pass		
§15.247(a)(1)	Carrier frequency separation	21	Site 1	Pass		
§15.247(a)(1)(iii)	Number of hopping frequencies	24	Site 1	Pass		
§15.247(a)(1)(iii)	Dwell Time	26	Site 1	Pass		
§15.247(e)	Power spectral density*			N/A		
§15.247(d)	Spurious RF conducted emissions	29	Site 1	Pass		
§15.247(d)	Band edge	33	Site 1	Pass		
§15.247(d) & §15.209 &	Spurious radiated emissions for transmitter and receiver	38	Site 1	Pass		
§15.203	Antenna requirement	See	note 2	Pass		

Note 1: N/A=Not Applicable.

Note 2: The EUT uses a permanently PCB antenna, which gain is 0dBi. In accordance to §15.203, It is considered sufficiently to comply with the provisions of this section.



General Remarks

Remarks

This submittal(s) (test report) is intended for FCC ID: A6JD40, complies with Section 15.207, 15.209, 15.247 of the FCC Part 15, Subpart C.

ISOUND-6710 is identical with WIP-D40, the difference only lies in the model name, so all the tests were applied on WIP-D40, ISOUND-6710 is deemed to fulfil the EMC requirement without further testing.

SUMMARY:

All lesis according to the regulations cited on page 5 we	he regulations cited on page 5 we	cited on	lations	regu	o the	ing to	accordii	All tests
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- Performed
- ☐ Not Performed

The Equipment Under Test

- - Fulfills the general approval requirements.
- □ **Does not** fulfill the general approval requirements.

Sample Received Date: January 9, 2015

January 13, 2015 Testing Start Date:

Testing End Date: January 21, 2015

TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch

Reviewed by: Prepared by: Tested by:

Phoebe Hu

EMC Project Manager

Calvin Weng **EMC Project Engineer**

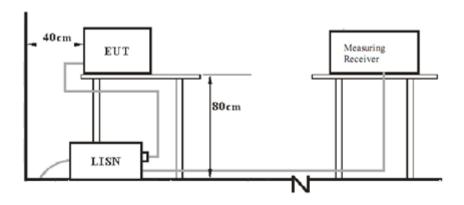
Leon Zhang **EMC Test Engineer**

Leon 2

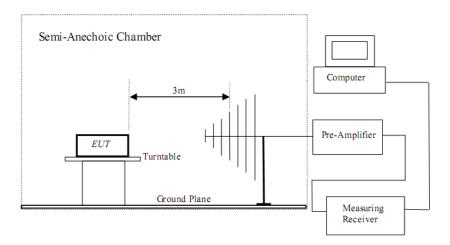


7 Test Setups

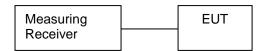
7.1 AC Power Line Conducted Emission test setups



7.2 Radiated test setups



7.3 Conducted RF test setups





8 Systems test configuration

Auxiliary Equipment Used during Test:

	DESCRIPTION	MANUFACTURER	MODEL NO.(SHIELD)	S/N(LENGTH)
ſ	NoteBook	LENOVO	X240	

Test software: BK3256 RF Test_V1.3.exe, which used to control the EUT in continues transmitting mode

The system was configured to hopping mode and non-hopping mode.

Hopping mode: typical working mode (normal hopping status)

Non-hopping mode: The system was configured to operate at a signal channel transmitting. The test software allows the configuration and operation at the worst-case duty and the highest transmit power



9 Technical Requirement

9.1 Conducted Emission on AC power port

Test Method

- 1. The EUT was placed on a table, which is 0.8m above ground plane
- 2. The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.).
- 3. Maximum procedure was performed to ensure EUT compliance
- 4. A EMI test receiver is used to test the emissions from both sides of AC line

Limit

According to §15.207, conducted emissions limit as below:

Frequency	QP Limit	AV Limit	
MHz	dΒμV	dΒμV	
 0.150-0.500	66-56*	56-46*	
0.500-5	56	46	
5-30	60	50	

Decreasing linearly with logarithm of the frequency



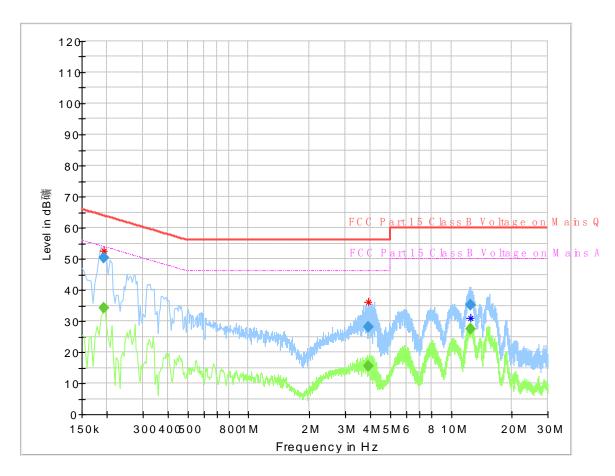
Product Type : Wireless Speaker

M/N : WIP-D40

Operating Condition : Charging + BT transmitting

Test Specification : Line

Comment : AC 120V/60Hz



Frequency	QuasiPeak	Average	Limit	Margin	Line	Corr.
(MHz)	(dBµV)	(dBµV)	(dBµV)	(dB)		(dB)
0.193500		34.21	53.88	19.67	L1	9.7
0.193500	50.35		63.88	13.53	L1	9.7
3.914500		15.62	46.00	30.38	L1	9.9
3.914500	27.95		56.00	28.05	L1	9.9
12.473500		27.37	50.00	22.63	L1	10.0
12.473500	35.32		60.00	24.68	L1	10.0

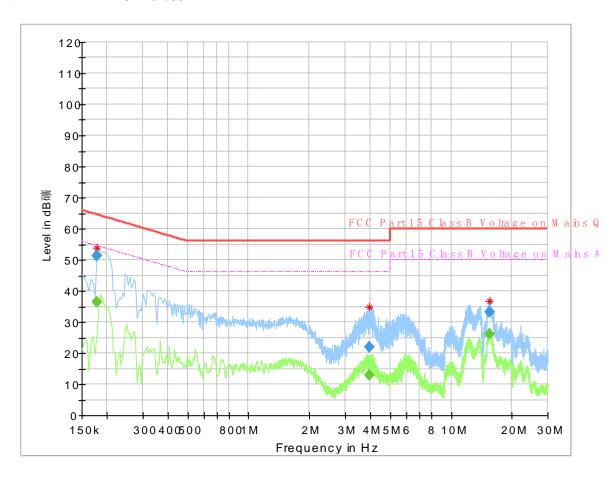


Product Type : Wireless Speaker

M/N : WIP-D40

Operating Condition : Charging + BT transmitting

Test Specification : Neutral Comment : AC 120V/60Hz



Frequency	QuasiPeak	Average	Limit	Margin	Line	Corr.
(MHz)	(dBµV)	(dBµV)	(dBµV)	(dB)		(dB)
0.177500		36.43	54.60	18.17	N	9.7
0.177500	51.35		64.60	13.25	N	9.7
3.965500		13.05	46.00	32.95	N	9.8
3.965500	21.91		56.00	34.09	N	9.8
15.405500		26.08	50.00	23.92	N	10.0
15.405500	33.19		60.00	26.81	N	10.0

9.2 Conducted peak output power

Test Method

- Use the following spectrum analyzer settings:
 Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel RBW > the 20 dB bandwidth of the emission being measured, VBW≥RBW, Sweep = auto, Detector function = peak, Trace = max hold
- 2. Add a correction factor to the display.
- 3. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power

Limits

According to §15.247 (b) (1), conducted peak output power limit as below:

Frequency Range	Limit	Limit
MHz	W	dBm
2400-2483.5	≤1	≤30

Test result as below table

Bluetooth Mode GFSK modulation Test Result

Frequency MHz	Conducted Peak Output Power dBm	Result
Low channel 2402MHz	0.81	Pass
Middle channel 2440MHz	0.68	Pass
High channel 2480MHz	-0.48	Pass

Bluetooth Mode $\pi/4$ -DQPSK modulation Test Result

	Conducted Peak	
Frequency	Output Power	Result
MHz	dBm	
Low channel 2402MHz	0.30	Pass
Middle channel 2440MHz	0.38	Pass
High channel 2480MHz	-0.74	Pass

Bluetooth Mode 8DPSK modulation Test Result

Frequency MHz	Conducted Peak Output Power dBm	Result
Low channel 2402MHz	0.53	Pass
Middle channel 2440MHz	0.62	Pass
High channel 2480MHz	-0.51	Pass



9.3 20 dB bandwidth and 99% Occupied Bandwidth

Produc

Test Method

- Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- 2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- 3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
- 4. Repeat above procedures until all frequencies measured were complete.

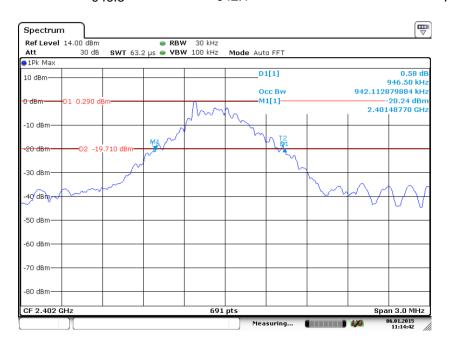
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Limit [kHz]
N/A



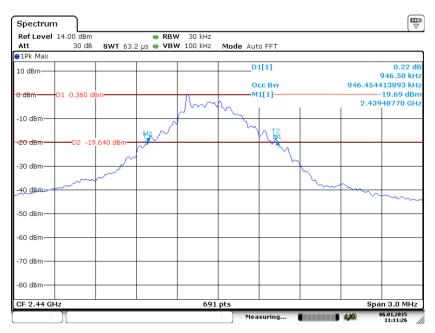
Bluetooth Mode GFSK Modulation test result

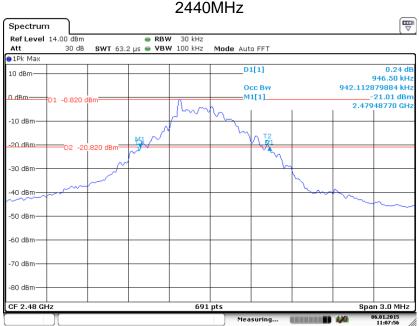
Frequency	20 dB Bandwidth	99% Bandwidth	Limit	Result	
MHz	kHz	kHz	kHz		
2402	946.5	942.1		Pass	
2440	946.5	946.5		Pass	
2480	946.5	942.1		Pass	



2402MHz





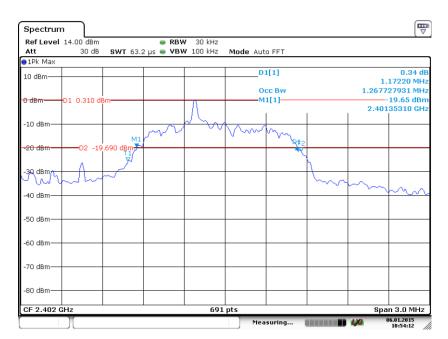


2480MHz

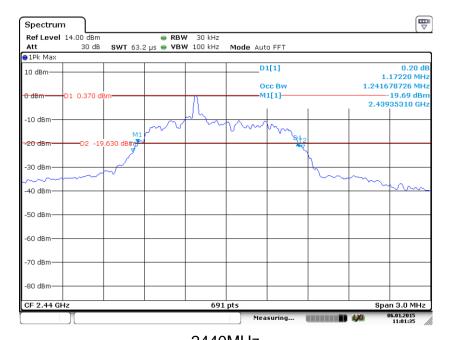


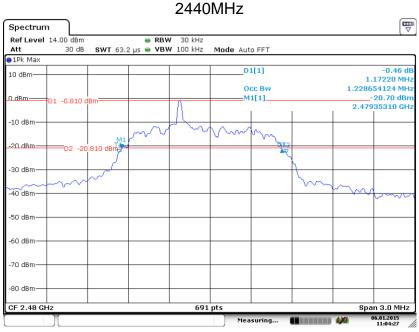
Bluetooth Mode π/4-DQPSK Modulation test result

Frequency	20 dB Bandwidth	99% Bandwidth	Limit	Result	
MHz	kHz	kHz	kHz		
2402	1172.2	1267.7		Pass	
2440	1172.2	1241.7		Pass	
2480	1172.2	1228.7		Pass	



2402MHz



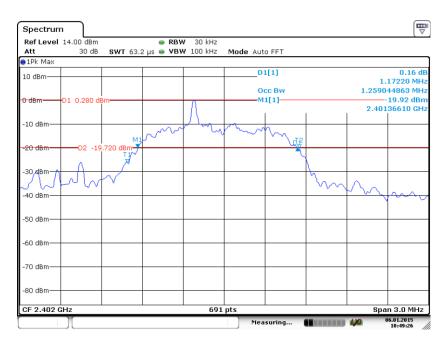


2480MHz

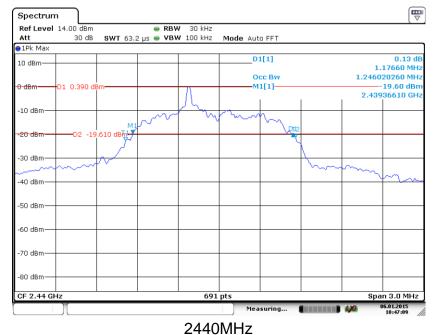


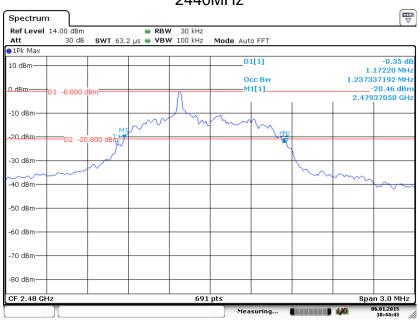
Bluetooth Mode 8DPSK Modulation test result

Frequency	20 dB Bandwidth	99% Bandwidth	Limit	Result	
MHz	kHz	kHz	kHz		
2402	1172.2	1259.0		Pass	
2440	1176.6	1246.0		Pass	
2480	1172.2	1237.3		Pass	



2402MHz





2480MHz



9.4 Carrier Frequency Separation

Test Method

- Use the following spectrum analyzer settings:
 Span = wide enough to capture the peaks of two adjacent channels, RBW ≥ 1% of the span, VBW) ≥RBW, Sweep = auto, Detector function = peak
- 2. By using the Max-Hold function record the separation of two adjacent channels.
- 3. Measure the frequency difference of these two adjacent channels by spectrum analyzer marker function.
- 4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit
kHz
≥25KHz or 2/3 of the 20 dB bandwidth which is greater

GFSK Modulation Limit

Frequency	2/3 of 20 dB Bandwidth	
MHz	kHz	
2402	631	
2440	631	
2480	631	

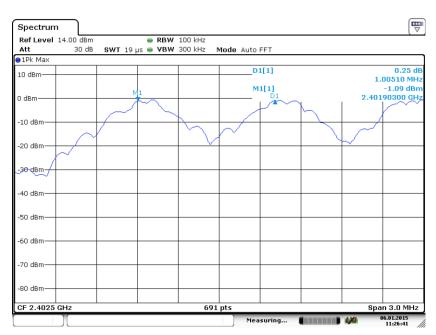


Carrier Frequency Separation

Test result: The measurement was performed with the typical configuration (normal hopping status), here GFSK modulation mode was used to show compliance.

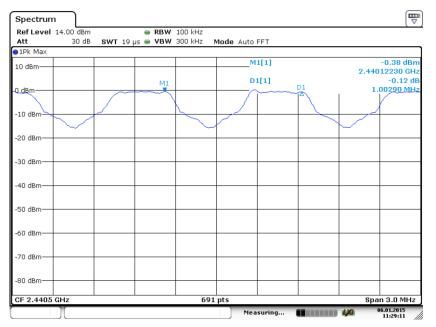
GFSK Modulation test result

Frequency Carrier Frequency Separation		Result
MHz	kHz	
2402	1005	Pass
2440	1003	Pass
2480	1003	Pass



2402MHz



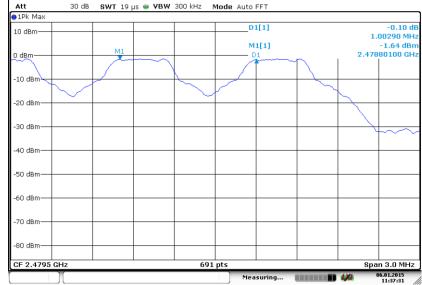


Date: 6.JAN.2015 11:29:11

Ref Level 14.00 dBm

Spectrum

● RBW 100 kHz SWT 19 µs ● VBW 300 kHz Mode Auto FFT D1[1]



2440MHz

2480MHz



9.5 Number of hopping frequencies

Test Method

- Use the following spectrum analyzer settings:
 Span = wide enough to capture the peaks of two adjacent channels, RBW ≥ 1% of the span, VBW) ≥RBW, Sweep = auto, Detector function = peak
- 2. Set the spectrum analyzer on Max-Hold Mode, and then keep the EUT in hopping mode.
- 3. Record all the signals from each channel until each one has been recorded.
- 4. Repeat above procedures until all frequencies measured were complete.

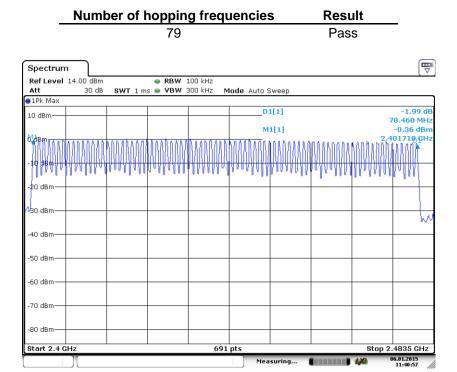
Limit

Limit
number
 ≥ 15



Number of hopping frequencies

Test result: The measurement was performed with the typical configuration (normal hopping status), and the total hopping channels is constant for the all modulation mode according with the Bluetooth Core Specification. Here GFSK modulation mode was used to show compliance.



9.6 Dwell Time

Test Method

- Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.
 Equipment mode: Spectrum analyzer
- 2. RBW: 1MHz; VBW: 1MHz; SPAN: Zero Span
- 3. Adjust the center frequency of spectrum analyzer on any frequency be measured.
- 4. Measure the Dwell Time by spectrum analyzer Marker function.
- 5. Repeat above procedures until all frequencies measured were complete.

Limit

According to §15.247(a)(1)(iii) . The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.



Dwell Time

Dwell time

The maximum dwell time shall be 0,4 s.

According to the Bluetooth Core Specification, the worse result (DH5 mode) was reported to show compliance.

The Dwell Time = Burst Width * Total Hops. The detailed calculations are showed as follows: The duration for dwell time calculation: 0.4 [s] * hopping number = 0.4 [s] * 79 [ch] = 31.6 [s*ch];

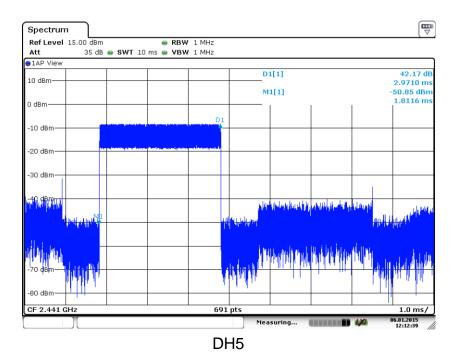
The burst width, which is directly measured, refers to the duration on one channel hop.

The maximum number of hopping channels in 31.6s for DH5=1600 / 6 / 79 *31.6=106.67

Test Result

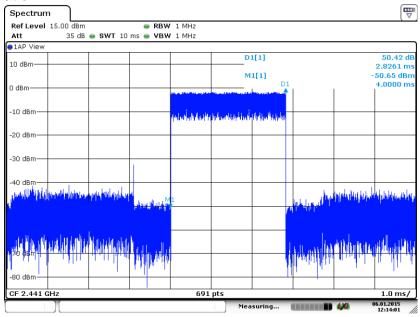
Modulation	Mode	Reading (µs)	Total Hops	Test Result (ms)	Limit (ms)	Result
GFSK	DH5	2971	106.67	316.92	< 400	Pass
π/4-DQPSK	2DH5	2826	106.67	301.45	< 400	Pass
8-DPSK	3DH5	2797	106.67	298.36	< 400	Pass

GFSK Modulation



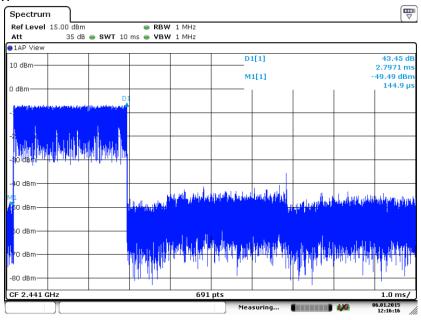


π/4-DQPSK Modulation



2DH5

8-DPSK Modulation



3DH5



9.7 Spurious RF conducted emissions

Test Method

- Use the following spectrum analyzer settings: Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10th harmonic. Typically, several plots are required to cover this entire span. RBW = 100 kHz, VBW≥RBW, Sweep = auto, Detector function = peak, Trace = max hold
- 2. Allow the trace to stabilize. Set the marker on the peak of any spurious emission recorded.
- 3. The level displayed must comply with the limit specified in this Section. Submit these plots.
- 4. Repeat above procedures until all frequencies measured were complete.

Limit

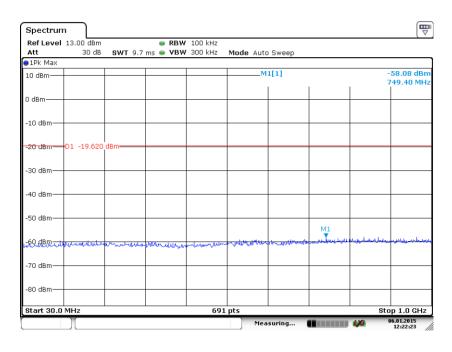
Frequency Range MHz	Limit (dBc)
30-25000	-20

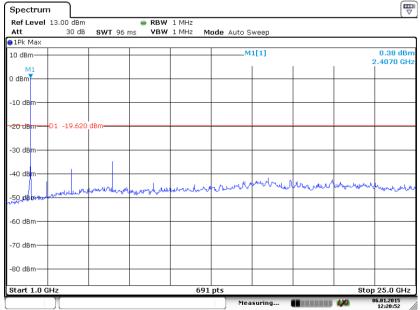


Spurious RF conducted emissions

Only the worse case (which is subject to the maximum EIRP, GFSK mode) test result is listed in the report.

2402MHz

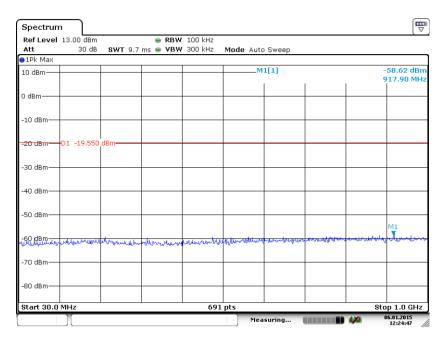


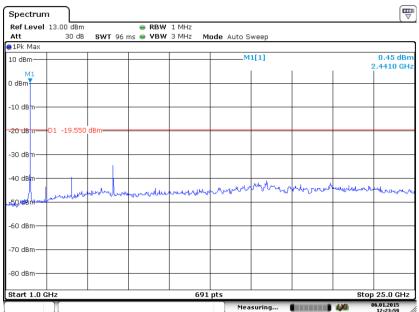




Spurious RF conducted emissions

2440MHz

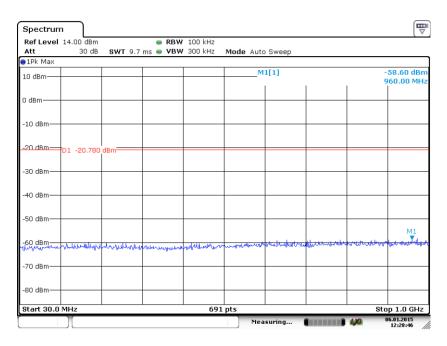


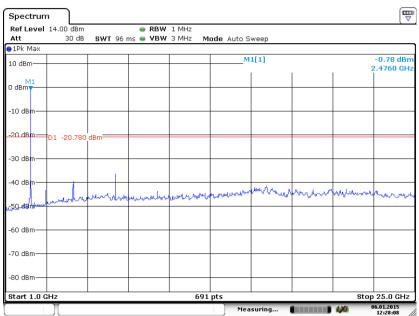




Spurious RF conducted emissions

2480MHz





9.8 Band edge testing

Test Method

1 Use the following spectrum analyzer settings:



Span = wide enough to capture the peak level of the in-band emission and all spurious RBW = 100 kHz, VBW ≥ RBW, Sweep = auto, Detector function = peak, Trace = max hold

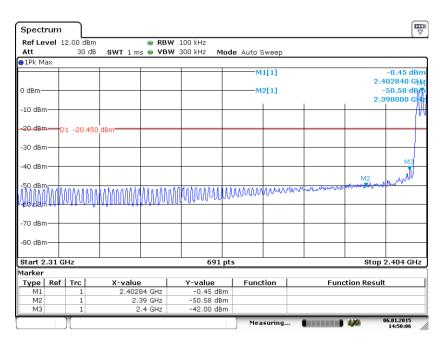
- 2 Allow the trace to stabilize, use the peak and delta measurement to record the result.
- 3 The level displayed must comply with the limit specified in this Section. .
- 4 Repeat the test at the hopping off and hopping on mode, submit all the plots.

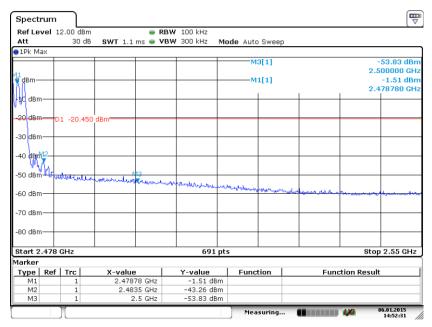
Limit:

According to §15.247(d), in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a) (see Section 15.205(c)).



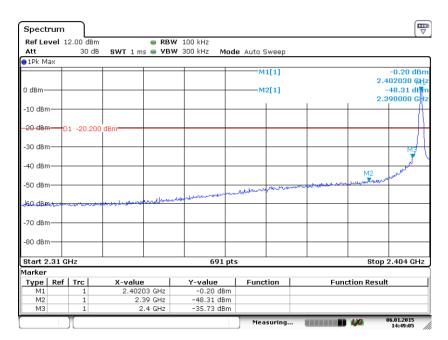
GFSK Modulation Test Result: Hopping on mode:

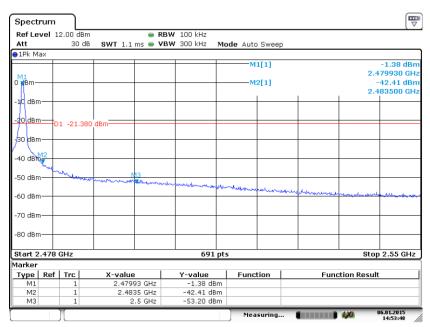






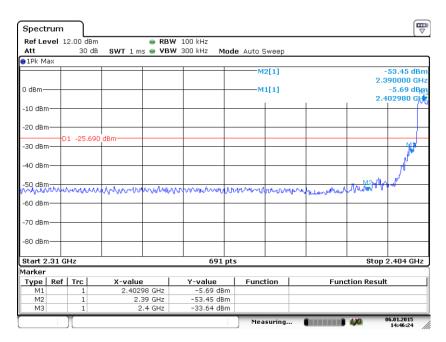
Hopping off mode:

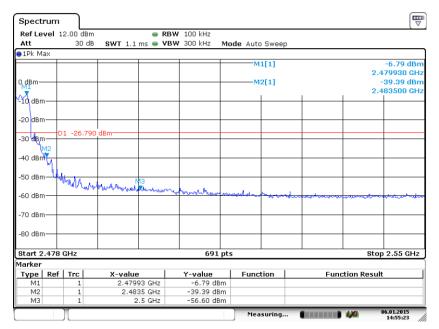






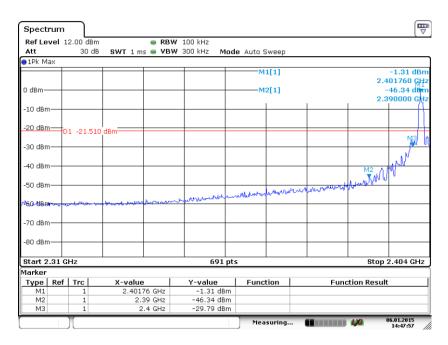
8DPSK Modulation Test Result: Hopping on mode:

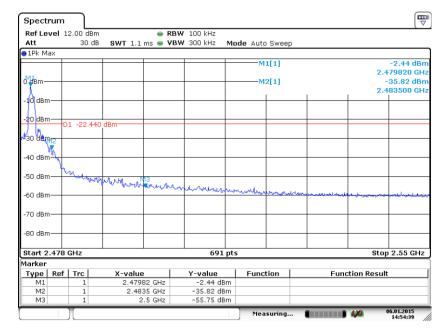






Hopping off mode:







9.9 Spurious radiated emissions for transmitter

Test Method

- 1. The EUT is placed on a turntable, which is 0.8m above ground plane.
- 2. EUT is set 3m away from the receiving antenna, which is varied from 1m to 4m to find out the highest emissions.
- 3. Use the following spectrum analyzer settings:

 Span = wide enough to fully capture the emission being measured, RBW = 1 MHz for f ≥

 1GHz, 100 kHz for f < 1 GHz, VBW ≥ RBW, Sweep = auto, Detector function = peak,

 Trace = max hold
- 4. Follow the guidelines in ANSI C63.4-2009 with respect to maximizing the emission by rotating the EUT, adjusting the measurement antenna height and polarization, etc. The peak reading of the emission, after being corrected by the antenna factor, cable loss, pre-amp gain, etc., is the peak field strength, submit this data. Each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 5. Set the VBW to 10 Hz, while maintaining all of the other instrument settings. This peak level, once corrected, must comply with the limit specified in Section 15.209. If the duty cycle per channel of the hopping signal is less than 100 ms, then the reading obtained with the 10 Hz VBW may be further adjusted by a "duty cycle correction factor", derived from 20log(duty cycle/100 ms), in an effort to demonstrate compliance with the 15.209 limit. Submit this data.

Limit

According to part 15.247(d), the radio emission outside the operating frequency band shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power. Radiated emissions which fall in the restricted bands, as defined in section 15.205, must comply with the radiated emission limits specified in section 15.209.

Frequency	Field Strength	Field Strength	Detector
MHz	uV/m	dBμV/m	
30-88	100	40	QP
88-216	150	43.5	QP
216-960	200	46	QP
960-1000	500	54	QP
Above 1000	500	54	AV
Above 1000	5000	74	PK



Spurious radiated emissions for transmitter

The only worse case (which is subject to the maximum EIRP, GFSK mode) test result is listed in the report.

Transmitting spurious emission test result as below:

Bluetooth Mode GFSK Modulation 2402MHz Test Result

Frequency	Emission Level	Polarization	Limit	Detector	Result
MHz	dBuV/m		dBµV/m		
213.6	26.75	Horizontal	43.5	QP	Pass
181.9	22.06	Vertical	43.5	QP	Pass
*4804	53.74	Horizontal	74	PK	Pass
*4804	44.14	Horizontal	54	AV	Pass
*4804	50.02	Vertical	74	PK	Pass
*4804	40.42	Vertical	54	AV	Pass
*7206	56.50	Horizontal	74	PK	Pass
*7206	46.90	Horizontal	54	AV	Pass
*7206	57.52	Vertical	74	PK	Pass
*7206	47.92	Vertical	54	AV	Pass

Bluetooth Mode GFSK Modulation 2441MHz Test Result

Frequency	Emission Level	Polarization	Limit	Detector	Result
MHz	dBuV/m		dBµV/m		
*4882	53.50	Horizontal	74	PK	Pass
*4882	43.90	Horizontal	54	AV	Pass
*4882	50.64	Vertical	74	PK	Pass
*4882	41.04	Vertical	54	AV	Pass
*7323	56.09	Horizontal	74	PK	Pass
*7323	46.49	Horizontal	54	AV	Pass
*7323	56.42	Vertical	74	PK	Pass
*7323	46.82	Vertical	54	AV	Pass

Bluetooth Mode GFSK Modulation 2480MHz Test Result

Frequency	Emission Level	Polarization	Limit	Detector	Result
MHz	dBuV/m		dBµV/m		
*4960	47.53	Horizontal	74	PK	Pass
*4960	37.93	Horizontal	54	AV	Pass
*4960	48.27	Vertical	74	PK	Pass
*4960	38.67	Vertical	54	AV	Pass
*7440	49.57	Horizontal	74	PK	Pass
*7440	39.97	Horizontal	54	AV	Pass
*7440	52.17	Vertical	74	PK	Pass
*7440	42.57	Vertical	54	AV	Pass

Remark:

(1) AV Emission Level= PK Emission Level+20log(dutycycle)=PK Emission Level-9.6



- (2) Data of measurement within this frequency range shown "-" in the table above means the reading of emissions are attenuated more than 20db below the permissible limits or the field strength is too small to be measured.
- (3) "*" means the emission(s) appear within the restrict bands shall follow the requirement of section 15.205.



10 Test Equipment List

List of Test Instruments

	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE	
	EMI Test Receiver	Rohde & Schwarz	ESR 3	101782	2015-8-17	
	LISN	Rohde & Schwarz	ENV4200	100249	2015-8-17	\boxtimes
	LISN	Rohde & Schwarz	ENV216	100326	2015-8-17	
CE	ISN	Rohde & Schwarz	ENY81	100177	2015-8-17	
	ISN	Rohde & Schwarz	ENY81- CAT6	101664	2015-8-17	
	High Voltage Proble	Rohde & Schwarz	TK9420(VT9 420)	9420-58	2015-8-17	
	RF Current probe	Rohde & Schwarz	EZ-17	100816	2015-8-17	
С	Signal Analyzer	Rohde & Schwarz	FSV40	101030	2015-8-17	\boxtimes
RE	EMI Test Receiver	Rohde & Schwarz	ESR 26	101269	2015-8-17	\boxtimes
	Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9163	707	2017-8-17	
	Horn Antenna	Rohde & Schwarz	HF907	102294	2017-8-17	\boxtimes
	Pre-amplifier	Rohde & Schwarz	SCU 18	102230	2015-8-17	\boxtimes
	Pre-amplifier	Rohde & Schwarz	SCU 40A	100432	2015-8-17	\boxtimes
	3m Semi-anechoic chamber	TDK	9X6X6		2019-5-29	\boxtimes

C - Conducted RF tests

- · Conducted peak output power
- 6dB bandwidth*
- 20dB bandwidth and 99% Occupied Bandwidth
- Carrier frequency separation
- Number of hopping frequencies
- Dwell Time
- Power spectral density*
- Spurious RF conducted emissions
- Band edge

Note: "' means the test item doesn't applied.



11 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty

Items	Extended Uncertainty	
ILCIIIS	-	
Radiated spurious emission	4.89dB (30MHz-1GHz)	
Radiated Spurious emission	4.93dB (1GHz -25GHz)	
Conducted Emission	2.92dB (150kHz-30MHz)	
Conducted spurious emission	2.04dB(30MHz-25GHz)	
Bandwidth test	1*10 ⁻⁹	